

Temperature dependence of Johnson Noise

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OBJECTIVES:

1. Calibrating the Thermal probe by the 'Two-point calibration' method.
2. Controlling the temperature of the copper base in the range of 77K - 300K.
3. Measuring Johnson Noise of a resistor as a function of temperature.

THEORY: Johnson noise is characterised in terms of mean square voltage as $\langle v_J^2(t) \rangle = 4k_B RT \Delta f$.

We verified this relation for a given resistor within the appropriate bandwidth(Δf).

We used a thermal probe to measure the temperatures. The probe comes with a 'trans-diode' or 'diode-connected transistor' as the electrical transducer for temperature measurement. We used the I-V response of the ideal p-n diode operating at the current of $10\mu A$. It gives voltage in terms of temperature as $\Delta V(i=10\mu A, T) = d_1 - d_2 T - d_3 T \log(T)$. We get the value of d_1 , and d_2 by measuring the voltage at two known temperature points- room condition(298 K) and liquid Nitrogen boiling point(77K). The value of d_3 is supplied in the manual itself.

To control the temperature of the probe, we managed the power input to the heater by allowing a certain amount of current to pass through it. We get the desired temperature by setting a thermal equilibrium between heat delivered by the heater and heat dissipation to the surrounding atmosphere and liquid nitrogen.

PROCEDURE: We stabilized the system at four different temperatures by the method discussed above. For each fixed temperature we took the reading for all three remote¹ resistors $R_A=10\Omega$, $R_B=10k\Omega$ and $R_C=100k\Omega$. We did the same for local resistors located inside LLE².

OBSERVATION AND CALCULATIONS :

Table-1 (Calibrating thermal probe)

Experimental condition and their associated temperature	Voltage measured (Volt)
Temperature of the room = 298 K	0.431 V
Liquid nitrogen boiling point = 77 K	0.966 V

Putting these value in equation $[\Delta V(i=10\mu A, T)=d_1 - d_2 T - d_3 T \log(T)]$ ³ gives

$$\Delta V(i=10\mu A, T) = 1.10 - (8.15 \times 10^{-5})T - 4.05 \times 10^{-4} T \log(T).$$

Using this equation we get the temperature-voltage table as below. From the following table, we can infer the temperature by looking at the corresponding voltage. The voltmeter connected to the temperature module of LLE record the voltage.

¹ Remote resistor are embedded inside thermal probe and there are directly connected to temperature varying copper base.

² LLE refers to low level electronic device and resistors inside them are always near ambient temperature

³ Value of $d_3=0.431mV$ is given in manual to make 'two point calibration' method more precise.

voltage(volt)	Temperature(Kelvin)	voltage(volt)	Temperature(Kelvin)
0.966	77	0.523	260
0.922	100	0.465	280
0.874	120	0.441	290
0.825	140	0.427	300
0.775	160	0.386	320
0.723	180	0.305	340
0.671	200	0.258	360
0.618	220	0.184	380
0.564	240	0.113	400

TABLE-2(variation of johnson noise as temperature)

Bandwidth range: 1 kHz - 33 kHz. Measured Amplifier-noise⁴ $\langle V_N^2(t) \rangle = [2.50 \times 10^{-12} V^2]$

We calculated the effect of the **remote resistors** R_A , R_B and R_C

The voltage of DMM correspond to $\langle V_{sq}(t) \rangle$ which is related to johnson noise as

$$\langle V_{sq}(t) \rangle = \{(G_1 G_2)^2 / 10V\} \langle V_J^2(t) + V_N^2(t) \rangle ; \text{ where } G_1 = 600 \text{ and } G_2 \text{ managed using HLE}^5$$

For resistor $R_A = 10\Omega$

Temperature (K)	77	126	212	298
$\langle V_{sq}(t) \rangle (mV^2)$	4.11	4.18	4.30	4.58

For resistor $R_B = 10k\Omega$

Temperature (K)	77	126	212	298
$\langle V_{sq}(t) \rangle (mV^2)$	9.50	9.76	10.01	10.31

For resistor $R_B = 100k\Omega$

Temperature (K)	77	126	212	298
$\langle V_{sq}(t) \rangle (mV^2)$	13.72	13.89	14.29	14.75

⁴Amplifier noise only depends on bandwidth of operation and we are keeping the same bandwidth while taking all the readings.

⁵ HLE refers to high level electronics and it contains gain knobs to adjust appropriate G_2 .

Johnson noise for **resistors inside LLE** device which is always at **ambient temperature**

R=10 Ω

Temperature (K)	77	126	212	298
$\langle V_{sq}(t) \rangle (mV^2)$	4.56	4.56	4.57	4.58

Slight deviation in voltage due to small internal heating of resistors (Joule heating).

R=10k Ω

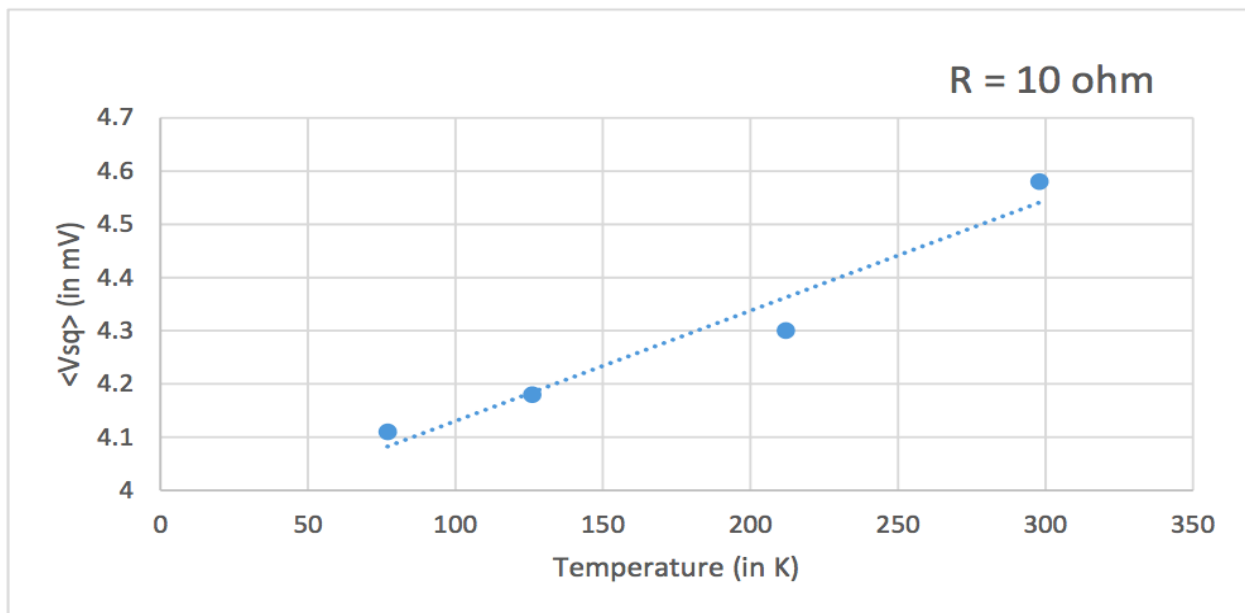
Temperature (K)	77	126	212	298
$\langle V_{sq}(t) \rangle (mV^2)$	10.30	10.31	10.31	10.31

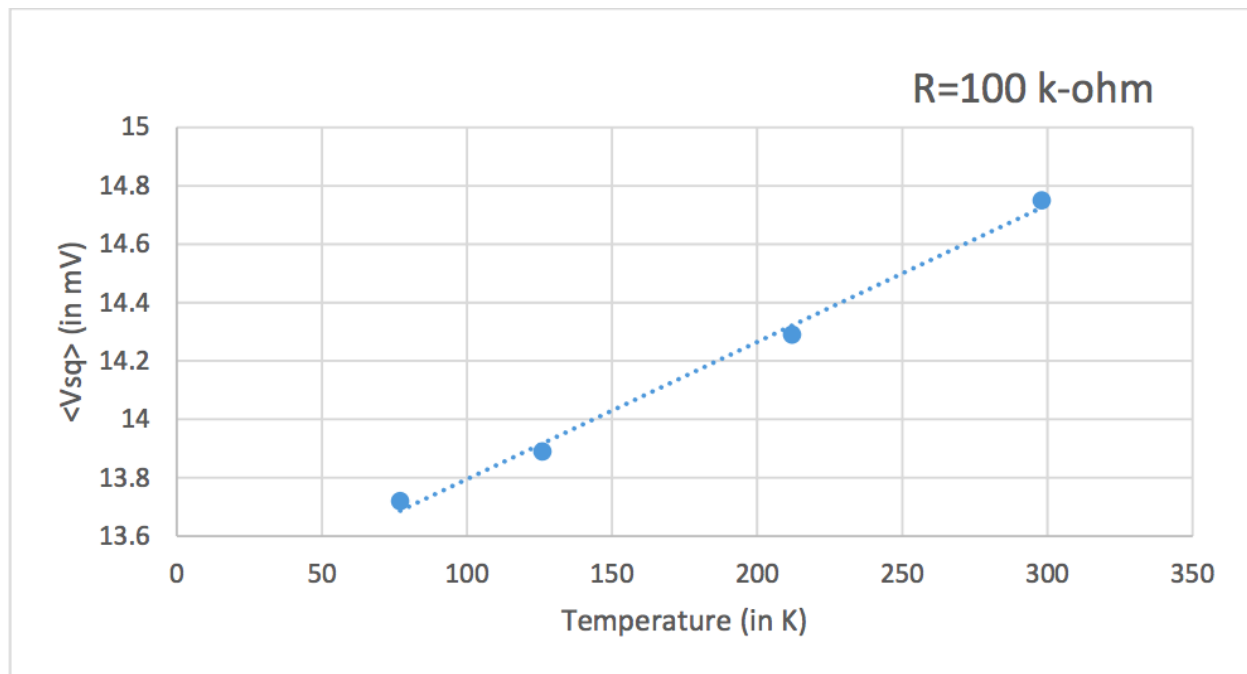
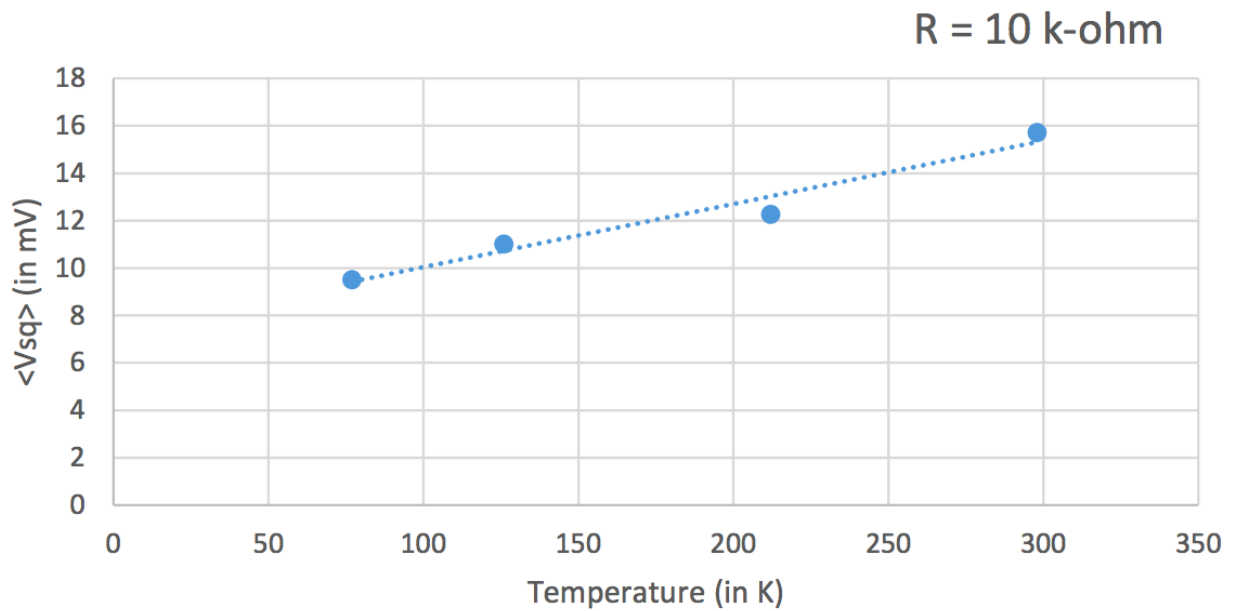
R=100k Ω

Temperature (K)	77	126	212	298
$\langle V_{sq}(t) \rangle (mV^2)$	14.73	14.74	14.74	14.74

Result: Above three observation table shows that resistor inside LLE are at same temperature hence no change in their Johnson noise.

Graph-A





Graph-C(above)

Slope calculation and % deviation of experimental result with the theory.

Experimental value of Slope calculation by *best fit line* of the graph

(i) For $R=10\Omega$ (Graph-A)

Slope = $0.00142 \text{ mV}^2\text{K}^{-1}$

(ii) For $R=10\text{k}\Omega$ (Graph-B)

Slope = $0.00281 \text{ mV}^2\text{K}^{-1}$

(iii) For $R = 100\text{k}\Omega$ (Graph-C)

$$\text{Slope} = 0.00466 \text{ mV}^2\text{K}^{-1}$$

Theoretical values of each slopes using the relation:

$$\langle V_{sq}(t) \rangle = \{(G_1 G_2)^2 / 10V\} \langle V_J^2(t) + V_N^2(t) \rangle \text{ and,}$$

$$\langle V_J^2(t) + V_N^2(t) \rangle = (4k_B R \Delta f) T \text{ which implies}$$

$$\text{Slop} = [\{(G_1 G_2)^2 / 10V\} (4k_B R \Delta f)] \text{ and y intercept} = V_N^2(t).$$

We are taking $k_B = 1.3 \times 10^{-23} \text{ m}^2\text{kg s}^{-2}\text{K}^{-1}$ and $\Delta f = 32 \text{ kHz}$ (controlled by HLE filter knobs)

For $R = 10\Omega$

Taking $G_1 = 1000$ $G_2 = 1500$

$$\text{Slope} = 0.0018 \text{ mV}^2\text{K}^{-1}$$

For $R = 10\text{k}\Omega$

Taking $G_1 = 600$ $G_2 = 1000$

$$\text{Slope} = 0.00241 \text{ mV}^2\text{K}^{-1}$$

For $R = 100\text{k}\Omega$

Taking $G_1 = 600$ $G_2 = 300$

$$\text{Slope} = 0.0059 \text{ mV}^2\text{K}^{-1}$$

	$R_A = 10\Omega$	$R_B = 10\text{k}\Omega$	$R_C = 100\text{k}\Omega$
Experimental slope	$0.00142 \text{ mV}^2\text{K}^{-1}$	$0.00281 \text{ mV}^2\text{K}^{-1}$	$0.00466 \text{ mV}^2\text{K}^{-1}$
Theoretical slope	$0.00181 \text{ mV}^2\text{K}^{-1}$	$0.00241 \text{ mV}^2\text{K}^{-1}$	$0.00592 \text{ mV}^2\text{K}^{-1}$
%Error in Slope	21.5%	16.5%	20.3%

Conclusion of our experiment:

1. Johnson noise in resistor shows linear dependence with absolute temperature.

Special Note: We are unable to address the exact reason for relatively high deviations. We hypothesize it could be due to less data points on each graphs and some possible error committed in calibration of the temperature probe.

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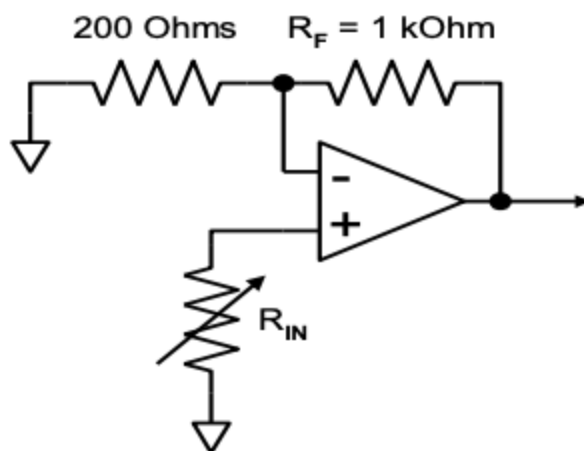
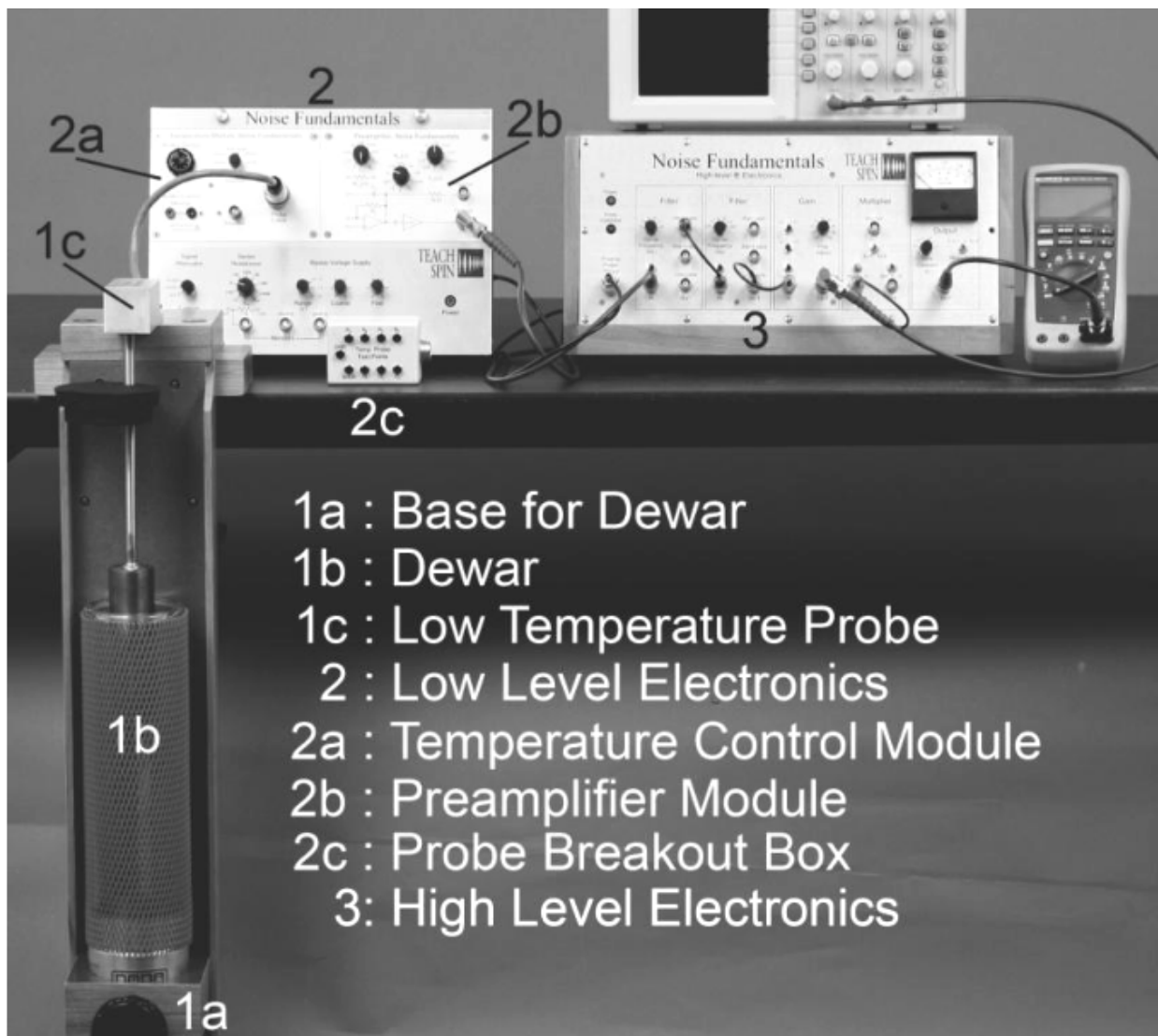
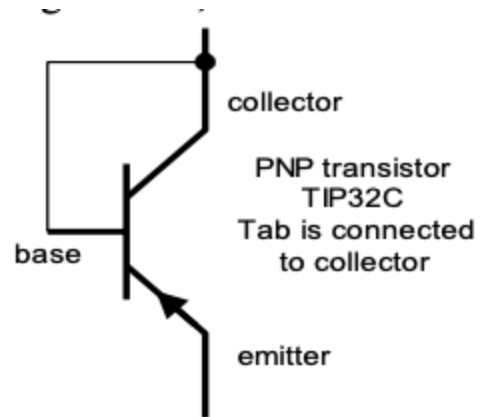


Fig 1.1a: Johnson noise preamplifier schematic



Schematic diagram for a pnp transistor in its transdiode configuration.